

# MOSFET - N-Channel, Shielded Gate, POWERTRENCH®

150 V, 25 A, 34 mΩ

## **FDMC86260**

#### **General Description**

This N-Channel MOSFET is produced using **onsemi**'s advanced POWERTRENCH process that incorporates Shielded Gate technology. This process has been optimized for the on-state resistance and yet maintain superior switching performance.

#### **Features**

- Shielded Gate MOSFET Technology
- Max  $R_{DS(on)} = 34 \text{ m}\Omega$  at  $V_{GS} = 10 \text{ V}$ ,  $I_D = 5.4 \text{ A}$
- Max  $R_{DS(on)} = 44 \text{ m}\Omega$  at  $V_{GS} = 6 \text{ V}$ ,  $I_D = 4.8 \text{ A}$
- High Performance Technology for Extremely Low R<sub>DS(on)</sub>
- 100% UIL Tested
- Pb-Free, Halide Free and RoHS Compliant

#### **Applications**

• DC-DC Conversion

#### MAXIMUM RATINGS (T<sub>A</sub> = 25°C unless otherwise noted)

| Symbol                            | Parameter   | Value                  | Unit |
|-----------------------------------|---|------------------------|------|
| V <sub>DS</sub>                   | Drain to Source Voltage   | 150                    | V    |
| $V_{GS}$                          | Gate to Source Voltage  | ±20                    | V    |
| I <sub>D</sub>                    | Drain Current: Continuous, $T_C = 25^{\circ}C$ (Note 5) Continuous, $T_C = 100^{\circ}C$ (Note 5) Continuous, $T_A = 25^{\circ}C$ (Note 1a) Pulsed (Note 4) | 25<br>16<br>5.4<br>135 | A    |
| E <sub>AS</sub>                   | Single Pulse Avalanche Energy (Note 3)  | 121                    | mJ   |
| P <sub>D</sub>                    | Power Dissipation:<br>T <sub>C</sub> = 25°C<br>T <sub>A</sub> = 25°C (Note 1a)  | 54<br>2.3              | W    |
| T <sub>J</sub> , T <sub>STG</sub> | Operating and Storage Junction<br>Temperature Range   | –55 to<br>+150         | °C   |

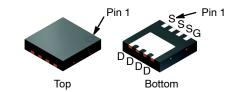
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL CHARACTERISTICS (T<sub>A</sub> = 25°C unless otherwise noted.)

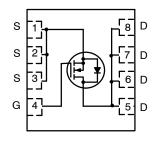
| Symbol          | Parameter  | Value | Unit |
|-----------------|--|-------|------|
| $R_{	heta JC}$  | Thermal Resistance,<br>Junction to Case (Note 1)     | 2.3   | °C/W |
| $R_{\theta JA}$ | Thermal Resistance,<br>Junction to Ambient (Note 1a) | 53    | °C/W |

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| V <sub>DS</sub> | R <sub>DS(ON)</sub> MAX | I <sub>D</sub> MAX |
|-----------------|-------------------------|--------------------|
| 150 V           | 34 mΩ @ 10 V            | 25 A               |
|                 | 44 mΩ @ 6 V             |                    |



WDFN8 3.3 × 3.3, 0.65P CASE 483AW



**N-CHANNEL MOSFET** 

#### **MARKING DIAGRAM**

ZXYYKK FDMC 86260 O

Z = Assembly Plant Code

XYY = 3-Digit Date Code Format

KK = 2-Alphanumeric Lot Run Traceability

Code

FDMC86260 = Specific Device Code

#### **ORDERING INFORMATION**

| Device    | Package                            | Shipping <sup>†</sup> |
|-----------|------------------------------------|-----------------------|
| FDMC86260 | WDFN8<br>(Pb–Free,<br>Halide Free) | 3000 /<br>Tape & Reel |

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise noted)

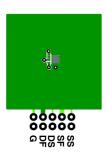
| Symbol                           | Parameter   | Test Condition   | Min | Тур  | Max  | Unit  |
|----------------------------------|---|--|-----|------|------|-------|
| FF CHARA                         | ACTERISTICS   | •  | •   | •    | •    | •     |
| BV <sub>DSS</sub>                | Drain to Source Breakdown Voltage                           | $I_D = 250 \mu A, V_{GS} = 0 V$  | 150 | _    | -    | V     |
| $\Delta BV_{DSS} / \Delta T_{J}$ | Breakdown Voltage Temperature<br>Coefficient                | I <sub>D</sub> = 250 μA, referenced to 25°C  | -   | 110  | -    | mV/°C |
| I <sub>DSS</sub>                 | Zero Gate Voltage Drain Current                             | V <sub>DS</sub> = 120 V, V <sub>GS</sub> = 0 V                                     | -   | -    | 1    | μΑ    |
| I <sub>GSS</sub>                 | Gate to Source Leakage Current                              | V <sub>GS</sub> = ±20 V, V <sub>DS</sub> = 0 V                                     | -   | -    | ±100 | nA    |
| ON CHARA                         | CTERISTICS  |  |     |      |      |       |
| V <sub>GS(th)</sub>              | Gate to Source Threshold Voltage                            | $V_{GS} = V_{DS}, I_D = 250 \mu A$   | 2   | 2.7  | 4    | V     |
| $\Delta V_{GS(th)} / \Delta T_J$ | Gate to Source Threshold Voltage<br>Temperature Coefficient | $I_D$ = 250 $\mu$ A, referenced to 25°C  | -   | -9   | -    | mV/°C |
| R <sub>DS(on)</sub>              | Static Drain to Source On Resistance                        | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 5.4 A                                     | _   | 27   | 34   | mΩ    |
|                                  |   | V <sub>GS</sub> = 6 V, I <sub>D</sub> = 4.8 A                                      | _   | 31   | 44   | 1     |
|                                  |   | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 5.4 A, T <sub>J</sub> = 125°C             | -   | 55   | 69   |       |
| 9FS                              | Forward Transconductance                                    | V <sub>DD</sub> = 10 V, I <sub>D</sub> = 5.4 A                                     | _   | 19   | _    | S     |
| YNAMIC C                         | HARACTERISTICS  |  |     |      |      |       |
| C <sub>iss</sub>                 | Input Capacitance   | V <sub>DS</sub> = 75 V, V <sub>GS</sub> = 0 V, f = 1 MHz                           | -   | 1000 | 1330 | pF    |
| C <sub>oss</sub>                 | Output Capacitance  |  | -   | 105  | 140  | pF    |
| C <sub>rss</sub>                 | Reverse Transfer Capacitance                                |  | -   | 4.8  | 10   | pF    |
| $R_g$                            | Gate Resistance   |  | 0.1 | 0.6  | 1.8  | Ω     |
| WITCHING                         | CHARACTERISTICS   |  |     |      |      |       |
| t <sub>d(on)</sub>               | Turn-On Delay Time  | $V_{DD} = 75 \text{ V}, I_D = 5.4 \text{ A}, V_{GS} = 10 \text{ V},$               | -   | 9.5  | 19   | ns    |
| t <sub>r</sub>                   | Rise Time   | $R_{GEN} = 6 \Omega$   | _   | 2    | 10   | ns    |
| t <sub>d(off)</sub>              | Turn-Off Delay Time   |  | _   | 17   | 30   | ns    |
| t <sub>f</sub>                   | Fall Time   |  | -   | 3.3  | 10   | ns    |
| Q <sub>g(TOT)</sub>              | Total Gate Charge   | V <sub>GS</sub> = 0 V to 10 V, V <sub>DD</sub> = 75 V,<br>I <sub>D</sub> = 5.4 A   | -   | 15   | 21   | nC    |
|                                  |   | $V_{GS} = 0 \text{ V to } 6 \text{ V}, V_{DD} = 75 \text{ V}, I_D = 5.4 \text{ A}$ | -   | 9.7  | 14   | nC    |
| Q <sub>gs</sub>                  | Gate to Source Charge                                       | V <sub>DD</sub> = 75 V, I <sub>D</sub> = 5.4 A                                     | -   | 4.0  | -    | nC    |
| $Q_{gd}$                         | Gate to Drain "Miller" Charge                               | V <sub>DD</sub> = 75 V, I <sub>D</sub> = 5.4 A                                     | -   | 3.1  | _    | nC    |

### **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted) (continued)

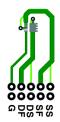
| Symbol                             | Parameter                             | Test Condition   | Min | Тур  | Max | Unit |
|------------------------------------|---------------------------------------|--|-----|------|-----|------|
| DRAIN-SOURCE DIODE CHARACTERISTICS |                                       |  |     |      |     |      |
| V <sub>SD</sub>                    | Source to Drain Diode Forward Voltage | V <sub>GS</sub> = 0 V, I <sub>S</sub> = 5.4 A (Note 2) | -   | 0.77 | 1.3 | V    |
|                                    |                                       | V <sub>GS</sub> = 0 V, I <sub>S</sub> = 1.9 A (Note 2) | -   | 0.72 | 1.2 |      |
| t <sub>rr</sub>                    | Reverse Recovery Time                 | I <sub>F</sub> = 5.4 A, di/dt = 100 A/μs               | _   | 64   | 102 | ns   |
| Q <sub>rr</sub>                    | Reverse Recovery Charge               |  | -   | 85   | 137 | nC   |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

1. R<sub>0,JA</sub> is determined with the device mounted on a 1 in2 pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R<sub>0,JC</sub> is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



a) 53°C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper.



b) 125°C/W when mounted on a minimum pad of 2 oz copper.

- Pulse Test: Pulse Width < 300 μs, Duty cycle < 2.0%.</li>
   E<sub>AS</sub> of 121 mJ is based on starting T<sub>J</sub> = 25°C, L = 3 mH, I<sub>AS</sub> = 9 A, V<sub>DD</sub> = 150 V, V<sub>GS</sub> = 10 V. 100% test at L = 0.1 mH, I<sub>AS</sub> = 22 A.
   Pulsed Id please refer to Figure 11 SAA graph for more details.
- 5. Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electro-mechanical application board design.

#### **TYPICAL CHARACTERISTICS**

(T<sub>J</sub> = 25°C unless otherwise noted)

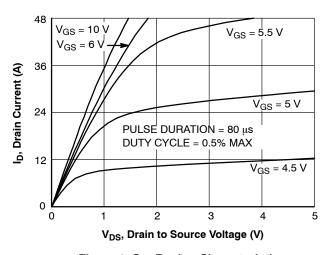


Figure 1. On-Region Characteristics

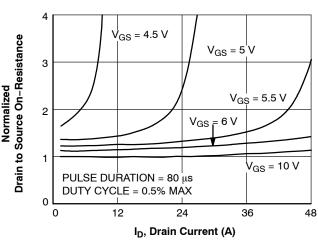


Figure 2. Normalized On–Resistance vs. Drain Current and Gate Voltage

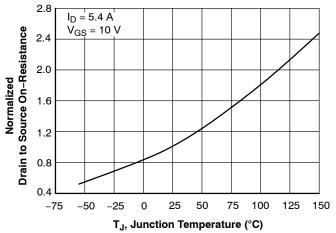


Figure 3. Normalized On–Resistance vs. Junction Temperature

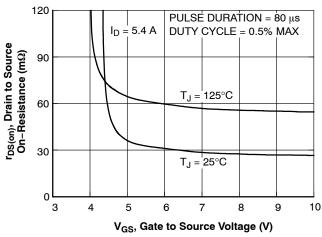


Figure 4. On-Resistance vs. Gate to Source Voltage

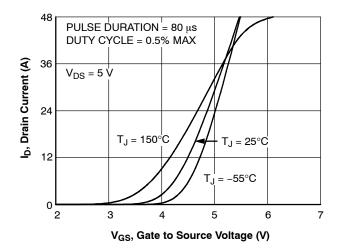


Figure 5. Transfer Characteristics

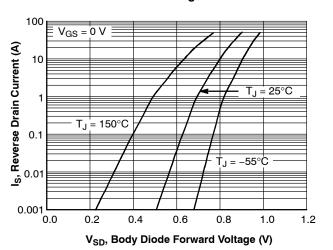


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

#### TYPICAL CHARACTERISTICS (continued)

(T<sub>J</sub> = 25°C unless otherwise noted)

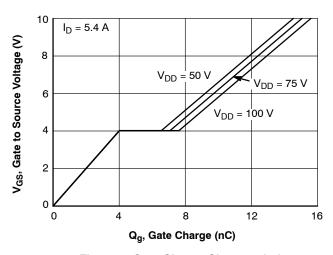


Figure 7. Gate Charge Characteristics

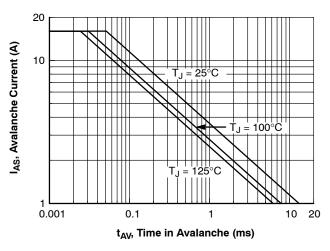


Figure 9. Unclamped Inductive Switching Capability

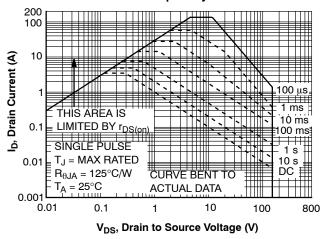


Figure 11. Forward Bias Safe Operating Area

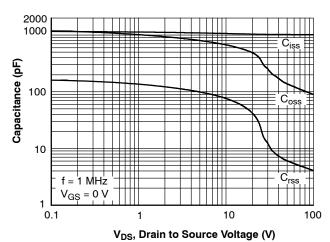


Figure 8. Capacitance vs. Drain to Source

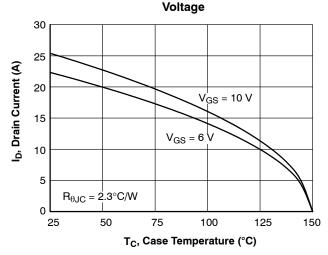


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

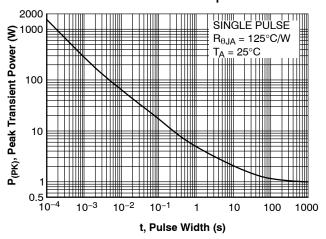


Figure 12. Single Pulse Maximum Power Dissipation

### TYPICAL CHARACTERISTICS (continued)

 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$ 

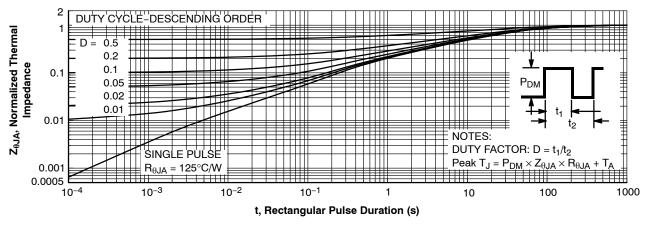


Figure 13. Junction-to-Ambient Transient Thermal Response Curve

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Α

5

TOP VIEW

В



TERMINAL #1

INDEX AREA

(D/2 X E/2)

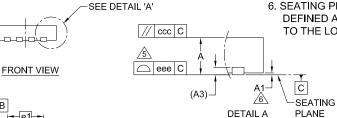
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#### WDFN8 3.30x3.30x0.75, 0.65P CASE 483AW ISSUE B

**DATE 22 MAR 2024** 

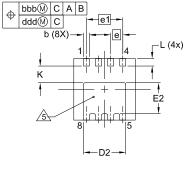
#### NOTES:

- 1. DIMENSIONING AND TOLERANCING CONFORM TO ASME Y14.5-2018.
- 2. ALL DIMENSIONS ARE IN MILLIMETERS.
- 3. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS.
- THE TERMINAL #1 IDENTIFIER AND TERMINAL NUMBERING CONVENTION SHALL CONFORM TO JEP95 SEC. 3 SPP-12. DETAILS OF TERMINAL #1 IDENTIFIER ARE OPTIONAL, BUT MUST BE LOCATED WITHIN THE ZONE INDICATED. THE TERMINAL #1 IDENTIFIER MAY BE EITHER A MOLD, EMBEDDED METAL OR MARKED FEATURE.
- ©COPLANARITY APPLIES TO THE EXPOSED PADS AS WELL AS THE TERMINALS.
- SEATING PLANE IS DEFINED BY THE TERMINALS. 'A1' IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.



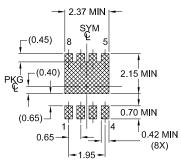
aaa C

2X



**BOTTOM VIEW** 

# LAND PATTERN RECOMMENDATION



\*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

| DIM   | MIL      | LIMETE   | RS   |  |
|-------|----------|----------|------|--|
| Diivi | MIN      | NOM      | MAX  |  |
| Α     | 0.70     | 0.75     | 0.80 |  |
| A1    |          |          | 0.05 |  |
| A3    | (        | 0.20 REF | •    |  |
| b     | 0.27     | 0.32     | 0.37 |  |
| D     | :        | 3.30 BSC | ;    |  |
| D2    | 2.17     | 2.27     | 2.37 |  |
| Е     | 3.30 BSC |          |      |  |
| E2    | 1.56     | 1.66     | 1.76 |  |
| е     | (        | 0.65 BSC | ;    |  |
| e1    |          | 1.95 BSC | ;    |  |
| K     | 0.90     |          |      |  |
| L     | 0.30     | 0.40     | 0.50 |  |
| aaa   | 0.10     |          |      |  |
| bbb   | 0.10     |          |      |  |
| ccc   | 0.10     |          |      |  |
| ddd   | 0.05     |          |      |  |
| eee   | 0.05     |          |      |  |
|       |          |          |      |  |

# GENERIC MARKING DIAGRAM\*



XXXX = Specific Device Code A = Assembly Location

Y = Year

WW = Work Week

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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| DESCRIPTION:     | WDFN8 3.30x3.30x0.75, 0.65P |   | PAGE 1 OF 1 |  |

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